


<b>Search Notes</b>  	<b>Application/Control No.</b>  10596769	<b>Applicant(s)/Patent Under Reexamination</b>  LEVENSHTEYN ET AL.
	<b>Examiner</b>  SUDHISH SURYAWANSI	<b>Art Unit</b>  4171

SEARCHED			
Class	Subclass	Date	Examiner
726	001, 2, 5, 9	11/13/2008	S.S.
713	157, 150, 155, 168, 229, 201	11/13/2008	S.S.
709	220, 223, 224, 225, 229	11/13/2008	S.S.
455	9, 24	11/13/2008	S.S.

SEARCH NOTES		
Search Notes	Date	Examiner
EAST, GOOGLE, IEEE, STIC	11/13/2008	S.S.

INTERFERENCE SEARCH			
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